

August 1998

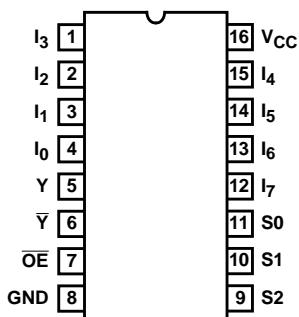
## 8-Input Multiplexer, Three-State

### Features

- Buffered Inputs
- Typical Propagation Delay
  - 6ns at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ ,  $C_L = 50pF$
- Exceeds 2kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-Resistant CMOS Process and Circuit Design
- Speed of Bipolar FAST™/AS/S with Significantly Reduced Power Consumption
- Balanced Propagation Delays
- AC Types Feature 1.5V to 5.5V Operation and Balanced Noise Immunity at 30% of the Supply
- $\pm 24mA$  Output Drive Current
  - Fanout to 15 FAST™ ICs
  - Drives  $50\Omega$  Transmission Lines

### Pinout

**CD74AC251, CD74ACT251  
(PDIP, SOIC)**  
TOP VIEW



### Description

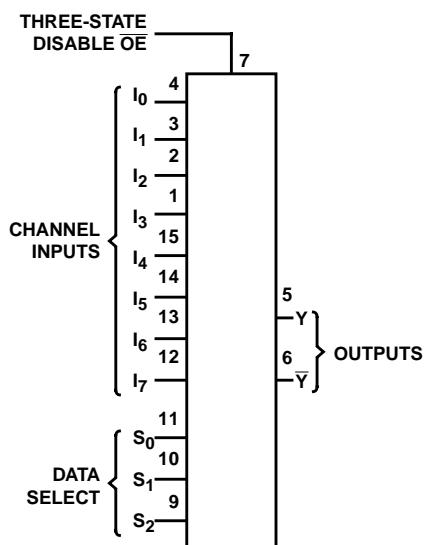
The CD74AC251 and CD74ACT251 8-input multiplexers that utilize the Harris Advanced CMOS Logic technology. This multiplexer features both true (Y) and complement ( $\bar{Y}$ ) outputs as well as an Output Enable ( $\bar{OE}$ ) input. The OE must be at a LOW logic level to enable this device. When the  $\bar{OE}$  input is HIGH, both outputs are in the high-impedance state. When enabled, address information on the data select inputs determines which data input is routed to the Y and  $\bar{Y}$  outputs.

### Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
CD74AC251E	0 to 70°C, -40 to 85, -55 to 125	16 Ld PDIP	E16.3
CD74ACT251E	0 to 70°C, -40 to 85, -55 to 125	16 Ld PDIP	E16.3
CD74AC251M	0 to 70°C, -40 to 85, -55 to 125	16 Ld SOIC	M16.15
CD74ACT251M	0 to 70°C, -40 to 85, -55 to 125	16 Ld SOIC	M16.15

#### NOTES:

1. When ordering, use the entire part number. Add the suffix 96 to obtain the variant in the tape and reel.
2. Wafer and die for this part number is available which meets all electrical specifications. Please contact your local sales office or Harris customer service for ordering information.

***Functional Diagram*****TRUTH TABLE**

INPUTS			OUTPUTS		
SELECT			OUTPUT ENABLE $\bar{OE}$	Y	$\bar{Y}$
S2	S1	S0			
X	X	X	H	Z	Z
L	L	L	L	$I_0$	$\bar{I}_0$
L	L	H	L	$I_1$	$\bar{I}_1$
L	H	L	L	$I_2$	$\bar{I}_2$
L	H	H	L	$I_3$	$\bar{I}_3$
H	L	L	L	$I_4$	$\bar{I}_4$
H	L	H	L	$I_5$	$\bar{I}_5$
H	H	L	L	$I_6$	$\bar{I}_6$
H	H	H	L	$I_7$	$\bar{I}_7$

H = High logic level, L = Low logic level, Z = High impedance (off),  
 X = Irrelevant,  $I_0, I_1 \dots I_7$  = The level of the respective input

**Absolute Maximum Ratings**

DC Supply Voltage, V <sub>CC</sub> .....	-0.5V to 6V
DC Input Diode Current, I <sub>IK</sub> For V <sub>I</sub> < -0.5V or V <sub>I</sub> > V <sub>CC</sub> + 0.5V.....	±20mA
DC Output Diode Current, I <sub>OK</sub> For V <sub>O</sub> < -0.5V or V <sub>O</sub> > V <sub>CC</sub> + 0.5V .....	±50mA
DC Output Source or Sink Current per Output Pin, I <sub>O</sub> For V <sub>O</sub> > -0.5V or V <sub>O</sub> < V <sub>CC</sub> + 0.5V .....	±50mA
DC V <sub>CC</sub> or Ground Current, I <sub>CC</sub> or I <sub>GND</sub> (Note 3) .....	±100mA

**Thermal Information**

Thermal Resistance (Typical, Note 5)	θ <sub>JA</sub> (°C/W)
PDIP Package .....	—
SOIC Package .....	—
Maximum Junction Temperature (Plastic Package) .....	150°C
Maximum Storage Temperature Range .....	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s) .....	300°C

**Operating Conditions**

Temperature Range, T <sub>A</sub> .....	-55°C to 125°C
Supply Voltage Range, V <sub>CC</sub> (Note 4)	
AC Types.....	1.5V to 5.5V
ACT Types .....	4.5V to 5.5V
DC Input or Output Voltage, V <sub>I</sub> , V <sub>O</sub> .....	0V to V <sub>CC</sub>
Input Rise and Fall Slew Rate, dt/dv	
AC Types, 1.5V to 3V .....	50ns (Max)
AC Types, 3.6V to 5.5V .....	20ns (Max)
ACT Types, 4.5V to 5.5V.....	10ns (Max)

*CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.*

## NOTES:

3. For up to 4 outputs per device, add ±25mA for each additional output.
4. Unless otherwise specified, all voltages are referenced to ground.
5. θ<sub>JA</sub> is measured with the component mounted on an evaluation PC board in free air.

**DC Electrical Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS		V <sub>CC</sub> (V)	25°C		-40°C TO 85°C		-55°C TO 125°C		UNITS
		V <sub>I</sub> (V)	I <sub>O</sub> (mA)		MIN	MAX	MIN	MAX	MIN	MAX	
<b>AC TYPES</b>											
High Level Input Voltage	V <sub>IH</sub>	-	-	1.5	1.2	-	1.2	-	1.2	-	V
				3	2.1	-	2.1	-	2.1	-	V
				5.5	3.85	-	3.85	-	3.85	-	V
Low Level Input Voltage	V <sub>IL</sub>	-	-	1.5	-	0.3	-	0.3	-	0.3	V
				3	-	0.9	-	0.9	-	0.9	V
				5.5	-	1.65	-	1.65	-	1.65	V
High Level Output Voltage	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.05	1.5	1.4	-	1.4	-	1.4	-	V
			-0.05	3	2.9	-	2.9	-	2.9	-	V
			-0.05	4.5	4.4	-	4.4	-	4.4	-	V
			-4	3	2.58	-	2.48	-	2.4	-	V
			-24	4.5	3.94	-	3.8	-	3.7	-	V
			-75 (Note 6, 7)	5.5	-	-	3.85	-	-	-	V
			-50 (Note 6, 7)	5.5	-	-	-	-	3.85	-	V

# CD74AC251, CD74ACT251

## DC Electrical Specifications (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		V <sub>CC</sub> (V)	25°C		-40°C TO 85°C		-55°C TO 125°C		UNITS
		V <sub>I</sub> (V)	I <sub>O</sub> (mA)		MIN	MAX	MIN	MAX	MIN	MAX	
Low Level Output Voltage	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.05	1.5	-	0.1	-	0.1	-	0.1	V
			0.05	3	-	0.1	-	0.1	-	0.1	V
			0.05	4.5	-	0.1	-	0.1	-	0.1	V
			12	3	-	0.36	-	0.44	-	0.5	V
			24	4.5	-	0.36	-	0.44	-	0.5	V
			75 (Note 6, 7)	5.5	-	-	-	1.65	-	-	V
			50 (Note 6, 7)	5.5	-	-	-	-	-	1.65	V
Input Leakage Current	I <sub>I</sub>	V <sub>CC</sub> or GND	-	5.5	-	±0.1	-	±1	-	±1	µA
Three-State Leakage Current	I <sub>OZ</sub>	V <sub>IH</sub> or V <sub>IL</sub> V <sub>O</sub> = V <sub>CC</sub> or GND	-	5.5	-	±0.5	-	±5	-	±10	µA
Quiescent Supply Current MSI	I <sub>CC</sub>	V <sub>CC</sub> or GND	0	5.5	-	8	-	80	-	160	µA
<b>ACT TYPES</b>											
High Level Input Voltage	V <sub>IH</sub>	-	-	4.5 to 5.5	2	-	2	-	2	-	V
Low Level Input Voltage	V <sub>IL</sub>	-	-	4.5 to 5.5	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.05	4.5	4.4	-	4.4	-	4.4	-	V
			-24	4.5	3.94	-	3.8	-	3.7	-	V
			-75 (Note 6, 7)	5.5	-	-	3.85	-	-	-	V
			-50 (Note 6, 7)	5.5	-	-	-	-	3.85	-	V
Low Level Output Voltage	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.05	4.5	-	0.1	-	0.1	-	0.1	V
			24	4.5	-	0.36	-	0.44	-	0.5	V
			75 (Note 6, 7)	5.5	-	-	-	1.65	-	-	V
			50 (Note 6, 7)	5.5	-	-	-	-	-	1.65	V
Input Leakage Current	I <sub>I</sub>	V <sub>CC</sub> or GND	-	5.5	-	±0.1	-	±1	-	±1	µA
Three-State or Leakage Current	I <sub>OZ</sub>	V <sub>IH</sub> or V <sub>IL</sub> V <sub>O</sub> = V <sub>CC</sub> or GND	-	5.5	-	±0.5	-	±5	-	±10	µA
Quiescent Supply Current MSI	I <sub>CC</sub>	V <sub>CC</sub> or GND	0	5.5	-	8	-	80	-	160	µA
Additional Supply Current per Input Pin TTL Inputs High 1 Unit Load	ΔI <sub>CC</sub>	V <sub>CC</sub> -2.1	-	4.5 to 5.5	-	2.4	-	2.8	-	3	mA

### NOTES:

- Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.
- Test verifies a minimum 50Ω transmission-line-drive capability at 85°C, 75Ω at 125°C.

**ACT Input Load Table**

INPUT	UNIT LOAD
S0, S1, S3	1
OE	1
I <sub>0</sub> - I <sub>7</sub>	1

NOTE: Unit load is  $\Delta I_{CC}$  limit specified in DC Electrical Specifications Table, e.g., 2.4mA max at 25°C.

**Switching Specifications** Input t<sub>r</sub>, t<sub>f</sub> = 3ns, C<sub>L</sub> = 50pF (Worst Case)

PARAMETER	SYMBOL	V <sub>CC</sub> (V)	-40°C TO 85°C			-55°C TO 125°C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
<b>AC TYPES</b>									
Propagation Delay, Data to Y Output	t <sub>PLH</sub> , t <sub>PHL</sub>	1.5	-	-	153	-	-	169	ns
		3.3 (Note 9)	4.9	-	17.2	4.7	-	18.9	ns
		5 (Note 10)	3.5	-	12.3	3.4	-	13.5	ns
Propagation Delay, Data to $\bar{Y}$ Output	t <sub>PLH</sub> , t <sub>PHL</sub>	1.5	-	-	169	-	-	186	ns
		3.3	5.4	-	19	5.2	-	20.9	ns
		5	3.8	-	13.5	3.7	-	14.9	ns
Propagation Delay, Select to Y Output	t <sub>PLH</sub> , t <sub>PHL</sub>	1.5	-	-	207	-	-	228	ns
		3.3	6.6	-	23.2	6.4	-	25.5	ns
		5	4.7	-	16.5	4.6	-	18.2	ns
Propagation Delay, Select to $\bar{Y}$ Output	t <sub>PLH</sub> , t <sub>PHL</sub>	1.5	-	-	223	-	-	245	ns
		3.3	7.1	-	24.9	6.9	-	27.4	ns
		5	5.1	-	17.8	4.9	-	19.6	ns
Propagation Delay, Output Enable and Output Disable to Output	t <sub>PZH</sub> , t <sub>PZL</sub> , t <sub>PHZ</sub> , t <sub>PLZ</sub>	1.5	-	-	155	-	-	169	ns
		3.3	5.2	-	18.7	5.1	-	20.3	ns
		5	3.5	-	12.3	3.4	-	13.5	ns
Three-State Output Capacitance	C <sub>O</sub>	-	-	-	15	-	-	15	pF
Input Capacitance	C <sub>I</sub>	-	-	-	10	-	-	10	pF
Power Dissipation Capacitance	C <sub>PD</sub> (Note 11)	-	-	120	-	-	120	-	pF
<b>ACT TYPES</b>									
Propagation Delay, Data to Y Output	t <sub>PLH</sub> , t <sub>PHL</sub>	5 (Note 10)	3.5	-	12.3	3.4	-	13.5	ns
Propagation Delay, Data to $\bar{Y}$ Output	t <sub>PLH</sub> , t <sub>PHL</sub>	5	3.8	-	13.5	3.7	-	14.9	ns
Propagation Delay, Select to Y Output	t <sub>PLH</sub> , t <sub>PHL</sub>	5	4.7	-	16.5	4.6	-	18.2	ns
Propagation Delay, Select to $\bar{Y}$ Output	t <sub>PLH</sub> , t <sub>PHL</sub>	5	5.1	-	17.8	4.9	-	19.6	ns
Propagation Delay, Output Enable and Output Disable to Output	t <sub>PZH</sub> , t <sub>PZL</sub> , t <sub>PHZ</sub> , t <sub>PLZ</sub>	5	3.5	-	12.3	3.4	-	13.5	ns

**Switching Specifications** Input  $t_r$ ,  $t_f = 3\text{ns}$ ,  $C_L = 50\text{pF}$  (Worst Case) (Continued)

PARAMETER	SYMBOL	V <sub>CC</sub> (V)	-40°C TO 85°C			-55°C TO 125°C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
Three-State Output Capacitance	$C_O$								
Input Capacitance	$C_I$	-	-	-	10	-	-	10	pF
Power Dissipation Capacitance	$C_{PD}$ (Note 11)	-	-	45	-	-	45	-	pF

## NOTES:

8. Limits tested 100%.
9. 3.3V Min is at 3.6V, Max is at 3V.
10. 5V Min is at 5.5V, Max is at 4.5V.
11.  $C_{PD}$  is used to determine the dynamic power consumption per device.  
 $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$  where  $f_i$  = input frequency,  $C_L$  = output load capacitance,  $V_{CC}$  = supply voltage.

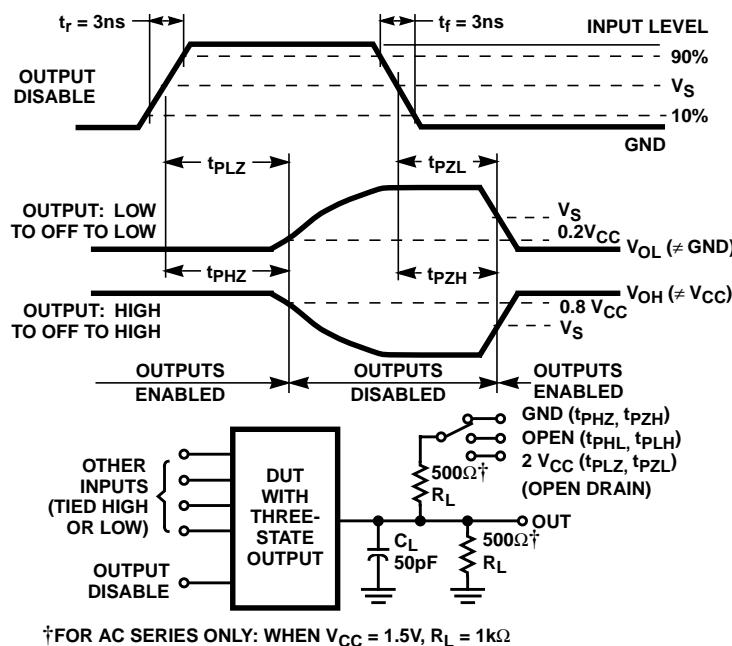


FIGURE 1. THREE-STATE PROPAGATION DELAY WAVEFORMS AND TEST CIRCUIT

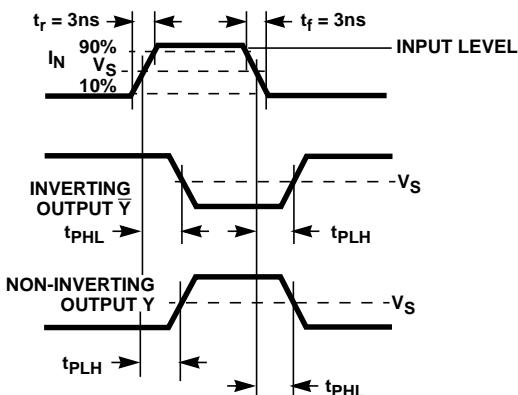
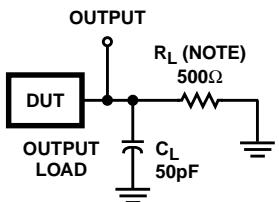


FIGURE 2. PROPAGATION DELAY TIMES

## ***CD74AC251, CD74ACT251***



NOTE: For AC Series Only: When  $V_{CC} = 1.5V$ ,  $R_L = 1k\Omega$ .

	<b>CD74AC</b>	<b>CD74ACT</b>
Input Level	$V_{CC}$	3V
Input Switching Voltage, $V_S$	0.5 $V_{CC}$	1.5V
Output Switching Voltage, $V_S$	0.5 $V_{CC}$	0.5 $V_{CC}$

**FIGURE 3. PROPAGATION DELAY TIMES**

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